

<b>Notice of References Cited</b>	Application/Control No. 10/727,043		Applicant(s)/Patent Under Reexamination TANABE ET AL.	
	Examiner Karen E. Toth		Art Unit 3735	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,884,221	04-2005	Narimatsu et al.	600/485
*	B	US-2003/0004422	01-2003	Narimatsu, Kiyoyuki	600/500
*	C	US-2003/0083580	05-2003	Tampo et al.	600/490
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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